

Search Notes

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10/790,880

Examiner

Denise Tran

Applicant(s)/Patent under
Reexamination

AKIYAMA ET AL.

Art Unit

2185

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
text search (USPAT, USPGPUB,USOCR,EPOAB,JPOAB,D ERWENT, IBM-TDB)	2/12/2007	DT
711/5,118,170,128-129,104,144; 365/230.03,185.11 (text search only search history)	2/12/2007	DT
711/103,105, 167; 365/189.01 (text search only search history)	2/16/2007	DT
inventor name search	2/12/2007	DT